


<b>Search Notes</b>  	<b>Application/Control No.</b>  10776736	<b>Applicant(s)/Patent Under Reexamination</b>  DEWAELE, PIET
	<b>Examiner</b>  Fujita, Katrina	<b>Art Unit</b>  2609

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Class	Subclass	Date	Examiner

SEARCH NOTES		
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